

Notice of References Cited

Application/Control No.

10/562,820

Applicant(s)/Patent Under

Reexamination

TAKAKUWA ET AL.

Examiner

DANIEL TEKLE

Art Unit

2621

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0031300	02-2005	Noguchi et al.	386/052
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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